

WSD6068DN56

Dual N-Ch MOSFET

General Description

The WSD6068DN56 is the highest performance trench Dual N-Ch MOSFET with extreme high cell density,which provide excellent R_{DSON} and gate charge for most of the synchronous buck converter applications .

The WSD6068DN56 meet the RoHS and Green Product requirement 100% EAS guaranteed with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

Absolute Maximum Ratings

Product Summery

BV _{DSS}		I _D
60V	12mΩ	25A

Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Fast switching
- Load Switch

DFN5X6-8L Pin Configuration



Symbol	Parameter	Rating	Unit		
Commo	n Ratings				
V_{DSS}	Drain-Source Voltage		60	V	
V_{GSS}	Gate-Source Voltage		±20	V	
TJ	Maximum Junction Temperature		150	°C	
T _{STG}	Storage Temperature Range		-55 to 175	°C	
ls	Diode Continuous Forward Current	T _c =25°C	25	Α	
I₀ Continu		T _c =25°C	25		
	Continuous Drain Current	T _c =70°C	18.5	A	
I _{DM} ^b	Pulse Drain Current Tested	T _c =25°C	95	А	
P _D Maximun		T _c =25°C	37	- w	
	Maximum Power Dissipation	T _c =70°C	25		
$R_{\theta JL}$	Thermal Resistance-Junction to Lead	Steady State	5	°C/W	
$R_{\theta JA}$ Them	Thermal Resistance-Junction to Ambient	$t \le 10s$	25	°C/W	
		Steady State ^b	90		
las ^d	Avalanche Current, Single pulse	L=0.5mH	9	Α	
E _{AS} ^d	Avalanche Energy, Single pulse	L=0.5mH	20	mJ	

Note a : Max. continuous current is limited by bonding wire.

Note b : Pulse width limited by max. junction temperature.

Note c : Surface mounted on $1in^2$ pad area, steady state t = 999s.

Note d : UIS tested and pulse width limited by maximum junction temperature $175^{\circ}C$ (initial temperature $T_i=25^{\circ}C$).



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Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Static Cha	racteristics		•			
BV_{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =250μA	60	-	-	V
-	Zero Gate Voltage Drain Current	V _{DS} =48V, V _{GS} =0V	-	-	1	μA
I _{DSS}		TJ=85°C	-	-	30	
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250μA	1.2	1.8	3.1	V
I _{GSS}	Gate Leakage Current	V_{GS} =±20V, V_{DS} =0V	-	-	±100	nA
		V _{GS} =10V, I _{DS} =10A	-	12	16	mΩ
R _{DS(ON)} ³	Drain-Source On-state Resistance	V _{GS} =4.5V, I _{DS} =7A	-	15	22	
Diode Cha	aracteristics	-				
V _{SD}	Diode Forward Voltage	I _{SD} =1A, V _{GS} =0V	-	0.75	1.2	V
t _{rr}	Reverse Recovery Time		-	26	-	ns
Q _r	Reverse Recovery Charge	I_{SD} =20A, dI _{SD} /dt=100A/µs	-	30	-	nC
Dynamic (Characteristics ^{3,4}				1	1
R _G	Gate Resistance	V _{GS} =0V,V _{DS} =0V,F=1MHz	-	0.9	-	Ω
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =30V,	-	440	570	pF
C _{oss}	Output Capacitance		-	198	-	
C _{rss}	Reverse Transfer Capacitance	F=1.0MHz Ω	-	57	-	
t _{d(ON)}	Turn-on Delay Time	VDD=30V, Ids=1A, Vgen=10V,	-	10	-	- ns
tr	Turn-on Rise Time		-	14.5	-	
$t_{d(OFF)}$	Turn-off Delay Time		-	19	-	
t _f	Turn-off Fall Time	R _G =3.3Ω.	-	28	-	
Gate Char	ge Characteristics ^{3,4}	-			1	
Qg	Total Gate Charge		-	8.6	-	nC
Q _{gs}	Gate-Source Charge	V _{DS} =30V, V _{GS} =10V,	-	2.7	-	
Q _{gd}	Gate-Drain Charge	I _{DS} =20A	_	6.3	_	

Note :

- 1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
- 2. $V_{DD}=30V, V_{GS}=10V, L=0.5mH, I_{AS}=9A., R_G=25\Omega$ Starting TJ=25
- 3. The data tested by pulsed , pulse width<=300us , duty cycle<=2%.
- 4. Essentially independent of operating temperature.



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Typical Operating Characteristics



T_c - Case Temperature (°C)



T_c - Case Temperature (°C)

Safe Operation Area



Thermal Transient Impedance



Square Wave Pulse Duration (sec)

Power Dissipation



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Typical Operating Characteristics(Cont.)





Typical Operating Characteristics(Cont.)

Capacitance



V_{DS} - Drain-Source Voltage (V)





Q_G - Gate Charge (nC)

Drain-Source On Resistance



T_i - Junction Temperature (°C)

Source-Drain Diode Forward



Gate Charge

V_{GS} - Gate-source Voltage (V)



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Packaging information





SYMBOLS	MILLIMETERS				
	MIN.	NOM.	MAX.		
А	0.90	1.05	1.20		
b	0.35	0.40	0.50		
С	0.20	0.25	0.35		
D	4.90	5.05	5.20		
D1/D2	1.51	1.61	1.71		
d	0.50	0.60	0.70		
E	6.00	6.15	6.30		
E1	5.60	5.75	5.90		
E2	3.47	3.57	3.67		
е		1.27 BSC.			
Н	0.48	0.58	0.68		
К	1.17	1.27	1.37		
L	0.64	0.74	0.84		
L1/L2		0.20 REF.			
θ	8 °	10°	12°		
М		0.08 REF.			
Ν	0	-	0.15		
0		0.25 REF.			
Р		1.28 REF.			



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